NDF60N550U1, NDD60N550U1

Features

Compliant

• 100% Avalanche Tested

Product Preview N-Channel Power MOSFET 600 V, 550 m Ω

• These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX		
600 V	550 mΩ @ 10 V		

ABSOLUTE MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Pa	Parameter				NDD	Unit
Drain-to-Source Voltage			V _{DSS}	600		V
Gate-to-Source	ce Voltage		V _{GS}	±25		V
Continuous Drain Current	Steady T _C = State 25°C		۱ _D	9.5	8.5	А
R _{θJC} (Note 1)		T _C = 100°C		6	5.4	
Power Dissipation – $R_{\theta JC}$	Steady State	T _C = 25°C	P _D	28	96	V
Pulsed Drain Current	t _p =	10 μs	I _{DM}	38	34	А
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to	9 +150	°C
Source Curren	Source Current (Body Diode)			9.5	8.5	Α
Single Pulse Drain-to-Source Avalanche Energy			EAS	TBD		mJ
Lead Temperature for Soldering Leads			ΤL	26	60	°C

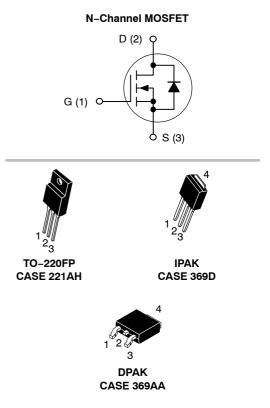
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Limited by maximum junction temperature

THERMAL RESISTANCE

Parameter	Symbol	Value	Unit	
Junction-to-Case (Drain)	NDF60N550U1 NDD60N550U1	$R_{\theta JC}$	4.4 1.3	°C/W
Junction-to-Ambient Steady	$R_{ hetaJA}$	50 33 96	°C/W	

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.



MARKING AND ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

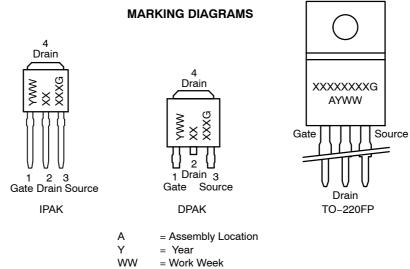
NDF60N550U1, NDD60N550U1

Characteristic	Symbol	Test Conditions		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 1 mA		600			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				TBD		mV/°C
Drain-to-Source Leakage Current	I _{DSS}	V_{DS} = 600 V, V_{GS} = 0 V	$T_J = 25^{\circ}C$			1	μA
			T _J = 125°C			50	
Gate-to-Source Leakage Current	I _{GSS}	V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{DS} = V_{GS}, I_D = 50$	μA	2	TBD	4	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	Reference to 25°C, I_D	= 50 μΑ		TBD		mV/°C
Static Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 4.	8 A		530	550	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _D = 4.	8 A		TBD		S
OYNAMIC CHARACTERISTICS					-	-	-
Input Capacitance	C _{iss}				540		pF
Output Capacitance	C _{oss}	V _{DS} = 50 V, V _{GS} = 0 V, f	= 1 MHz		45		
Reverse Transfer Capacitance	C _{rss}				1		
Total Gate Charge	Qg				20		nC
Gate-to-Source Charge	Q _{gs}	V _{DS} = 300 V, I _D = 9.5 A, V _{GS} = 10 V			TBD		
Gate-to-Drain Charge	Q _{gd}				TBD		
Plateau Voltage	V _{GP}		-		TBD		V
Gate Resistance	R _q				TBD		Ω
RESISTIVE SWITCHING CHARACTER	U						
Turn-on Delay Time	t _{d(on)}				TBD		ns
Rise Time	t _r	V _{DD} = 300 V, I _D = 9	.5 A.		TBD		
Turn-off Delay Time	t _{d(off)}	$V_{\rm DD}$ = 300 V, I _D = 9.5 A, V _{GS} = 10 V, R _G = 0 Ω			TBD		
Fall Time	t _f				TBD		
OURCE-DRAIN DIODE CHARACTER	ISTICS						
Diode Forward Voltage	V _{SD}	$T_{\rm J} = 25^{\circ}{\rm C}$			TBD	1.6	V
	$l_{s} = 9.5 \text{ A}, V_{cs} = 0 \text{ V}$	T _J = 100°C		TBD			
Reverse Recovery Time	t _{rr}	V _{GS} = 0 V, V _{DD} = 30 V I _S = 9.5 A, d _i /d _t = 100 A/μs			TBD		ns
Charge Time	ta				TBD		
Discharge Time	t _b				TBD		
Reverse Recovery Charge	Q _{rr}				TBD		nC

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

NDF60N550U1, NDD60N550U1



G = Pb–Free Package

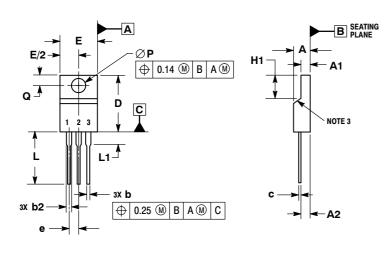
ORDERING INFORMATION

Device	Package	Shipping [†]
NDF60N550U1G	TO-220FP (Pb-Free, Halogen-Free)	50 Units / Rail
NDD60N550U1-1G	IPAK (Pb-Free, Halogen-Free)	75 Units / Rail
NDD60N550U1T4G	DPAK (Pb-Free, Halogen-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

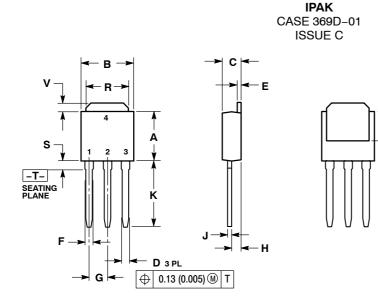
TO-220 FULLPACK, 3-LEAD CASE 221AH ISSUE C



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2. CONTROLLING DIMENSION: MILLIMETERS. 3. CONTOUR UNCONTROLLED IN THIS AREA. 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH AND GATE PROTRUSIONS. MOLD FLASH AND GATE PROTRUSIONS NOT TO EXCEED 0.13 PER SIDE. THESE DIMENSIONS ARE TO BE MEASURED AT OUTERMOST EXTREME OF THE PLASTIC BODY. 5. DIMENSION b2 DOES NOT INCLUDE DAMBAR PROTRUSION. LEAD WIDTH INCLUDING PROTRUSION SHALL NOT EXCEED 200.

	MILLIMETERS		
DIM	MIN	MAX	
Α	4.30	4.70	
A1	2.50	2.90	
A2	2.50	2.70	
b	0.54	0.84	
b2	1.10	1.40	
c	0.49	0.79	
D	14.70	15.30	
Е	9.70	10.30	
е	2.54	BSC	
H1	6.70	7.10	
Г	12.70	14.73	
L1		2.80	
Ρ	3.00	3.40	
Q	2.80	3.20	

PACKAGE DIMENSIONS



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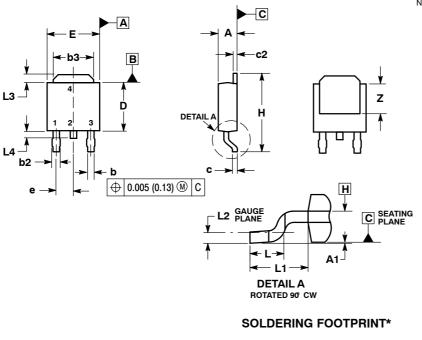
NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETER		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.35	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
Е	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.090	BSC	2.29 BSC		
н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
κ	0.350	0.380	8.89	9.65	
R	0.180	0.215	4.45	5.45	
S	0.025	0.040	0.63	1.01	
V	0.035	0.050	0.89	1.27	
Ζ	0.155		3.93		
STYLE 2:					

PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA-01 **ISSUE B**



6.20 3.00 0.244 0.118 2.58 0.102 5.80 6.17 1.60 0.228 0.063 0 243 $\left(\frac{mm}{inches}\right)$

NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME
- Y14.5M, 1994. 2. CONTROLLING DIMENSION: INCHES
- 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INCHES		INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX		
Α	0.086	0.094	2.18	2.38		
A1	0.000	0.005	0.00	0.13		
b	0.025	0.035	0.63	0.89		
b2	0.030	0.045	0.76	1.14		
b3	0.180	0.215	4.57	5.46		
С	0.018	0.024	0.46	0.61		
c2	0.018	0.024	0.46	0.61		
D	0.235	0.245	5.97	6.22		
Е	0.250	0.265	6.35	6.73		
е	0.090	BSC	2.29 BSC			
Н	0.370	0.410	9.40	10.41		
L	0.055	0.070	1.40	1.78		
L1	0.108 REF		2.74	REF		
L2	0.020	BSC	0.51 BSC			
L3	0.035	0.050	0.89	1.27		
L4		0.040		1.01		
Z	0.155		3.93			
STYLE 2:						

PIN 1. GATE 2. DRAIN 3 SOURCE

4. DRAIN

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SCALE 3:1

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